Integrated computation model of lithium-ion battery subject to nail penetration

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HIGHLIGHTS
- A coupling model to predict battery penetration process is established.
- Penetration test is designed and validates the computational model.
- Governing factors of the penetration induced short-circuit is discussed.
- Critical safety battery design guidance is suggested.

ABSTRACT
The nail penetration of lithium-ion batteries (LIBs) has become a standard battery safety evaluation method to mimic the potential penetration of a foreign object into LIB, which can lead to internal short circuit with catastrophic consequences, such as thermal runaway, fire, and explosion. To provide a safe, time-efficient, and cost-effective method for studying the nail penetration problem, an integrated computational method that considers the mechanical, electrochemical, and thermal behaviors of the jellyroll was developed using a coupled 3D mechanical model, a 1D battery model, and a short circuit model. The integrated model, along with the sub-models, was validated to agree reasonably well with experimental test data. In addition, a comprehensive quantitative analysis of governing factors, e.g., shapes, sizes, and displacements of nails, states of charge, and penetration speeds, was conducted. The proposed computational framework for LIB nail penetration was first introduced. This framework can provide an accurate prediction of the time history profile of battery voltage, temperature, and mechanical behavior. The factors that affected the behavior of the jellyroll under nail penetration were discussed systematically. Results provide a solid foundation for future in-depth studies on LIB nail penetration mechanisms and safety design.

1. Introduction
The sales of electrical vehicles (EVs) have increased in the last few years [1], and lithium-ion batteries (LIBs) have been regarded...
As promising alternative energy sources for use in EVs [2,3], LIB safety has become one of the main topics with regard to passenger safety because LIBs are frequently used in vehicles [4,5]. A thermal management system (TEM) is generally used to prevent overheating [6–8], but a short circuit may produce a significant amount of heat that may cause thermal runaway [9].

Nail penetration, which mimics the penetration of foreign objects into LIB during use, has become a standard LIB safety evaluation method [10]. The immediate consequences of nail penetration include the occurrence of internal short circuit, which has potentially catastrophic consequences, such as fire and explosion [11–13]. In general, engineers must perform time-consuming and hazardous nail penetration tests [10,14]. These tests involve inserting a steel nail into LIB, thereby bridging the positive and negative electrodes within the jellyroll and causing local internal short circuit among the component interfaces of the nail and the jellyroll. Although nail penetration is essentially a mechanical loading process, it may involve electrochemical and thermal behaviors, which result from the strong entanglement of the multiphysical fields within the battery. Thus, a reasonable modeling framework is urgently required to understand and control the complicated mechanisms of a nail penetration-induced thermal runaway or fire.

Numerical modeling is an ideal substitution for real-world nail penetration testing. First, pioneering efforts have been made to understand the mechanical behavior of LIBs that are subjected to bending [15] and loads. The constitutive model for the jellyroll was first established by Greve and Fehrenbach [15] and Sahraei et al. [18] through homogeneous isotropic material treatment. Since then, Lai et al. [16] developed a representative volume element (RVE) model that considered each component of the jellyroll. Recently, an anisotropic model with coupled strain rate and state of charge (SOC) dependencies was proposed in Ref. [19]. Second, with regard to electrochemical behavior, a 1D battery model was
first proposed by Newman et al. [20,21]. At present, such model is generally accepted as one of the most effective and accurate battery models. To improve the calibration of this battery model, the electrochemical properties of the cathode [11,22–24], anode [24–26], electrolyte [27,28], and separator [24,26] have been comprehensively studied. Third, internal short circuits have four types, as first discussed by Santhanagopalan et al. [29]. Fang et al. [11,30] conducted a numerical investigation of LIB short circuits using 3D model coupling that accounted for electrochemical and thermal influences. Recently, Chiu et al. [10] modeled thermal runaway behavior during the nail penetration process. Fourth, multi-physical simulations of LIBs have been developed by researchers [14,31–33]. These simulations typically involve electrochemical–thermal coupling [11,31,32] or individual jellyroll components [34–36]. By contrast, Zhang et al. [37] were the first to suggest using a coupled mechanical–electrochemical–thermal method to study short circuit behavior under a mechanical load.

Nevertheless, a mechanical model with accurate material failure under mechanical abuse loadings has not yet been established, thereby preventing precise prediction of the nail and jellyroll interface contact. Furthermore, excessive heat that ultimately leads to thermal runaway produced by a high current density and the redox reaction of lithium is also highly dependent on the previous mechanical loading and battery model. Few studies have attempted to provide a reasonable coupled computation model to solve the aforementioned emerging engineering problem for nail penetration.

Accordingly, an integrated mechanical–electrochemical–thermal coupled modeling method is proposed in this study to investigate the nail penetration problem by integrating a 1D battery model, a 3D failure model, and a coupled short circuit model. Section 2 describes the development and validation of the three models using 18650 LIB as the modeling target of the experiments. Section 3 presents the typical nail penetration test conducted to validate the coupled computation model. Section 4 discusses the parametric studies performed to investigate the governing factors of LIB behavior during nail penetration. Section 5 provides a summary of the main results and conclusions of the study.

2. Coupled computation modeling

2.1. Target 18650 lithium-ion battery

Commercial 18650 LIBs (SONY), with a capacity of 2200 mAh, were used in this study as the experiment validation target battery. The anode and cathode materials are LiC6 (thickness: mm) and LiCoO2 (thickness: 0.159 mm), respectively. The charge voltage and cutoff voltage are 4.2 V and 2.5 V, respectively. The basic dimensions are \( \phi 18.6 \text{ mm} \times 64.9 \text{ mm}. \) The jellyroll of the target LIB was studied individually. The dimensions of the jellyroll are summarized in Table 1.

2.2. 3D mechanical model

For simplicity, the 18650 LIB casing was not considered in both the experiments and the numerical modeling. In our previous study, a homogeneous anisotropic model of the jellyroll was developed [19] by considering SOC and dynamic effects; however, this homogenous model was incapable of indicating individual component failure. Thus, in the current study, the inner layers of the jellyroll were modeled using a homogeneous method to reflect the mechanical response of nail penetration, whereas the outer layers were configured layer by layer to describe the failure of each component (Fig. 1).

<table>
<thead>
<tr>
<th>Parameters</th>
<th>Values</th>
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<tbody>
<tr>
<td>( R^0 )</td>
<td>8.7 mm</td>
<td>Measured</td>
</tr>
<tr>
<td>( R^p )</td>
<td>2.5 mm</td>
<td>Measured</td>
</tr>
<tr>
<td>( \delta^j )</td>
<td>0.159 mm</td>
<td>Measured</td>
</tr>
<tr>
<td>( \delta^p )</td>
<td>0.165 mm</td>
<td>Measured</td>
</tr>
<tr>
<td>( \delta^e )</td>
<td>0.018 mm</td>
<td>Measured</td>
</tr>
<tr>
<td>( \delta^c )</td>
<td>0.013 mm</td>
<td>Measured</td>
</tr>
<tr>
<td>( \delta^s )</td>
<td>0.019 mm</td>
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</tr>
<tr>
<td>( H^p )</td>
<td>58.5 mm</td>
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</tr>
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Table 1: Geometric parameters of the models.

2.2.1. Modeling the inner layers of the jellyroll

At present, the jellyroll is conventionally regarded as a macroscopic homogeneous cylinder with an initial small hole on the surface. In this study, the mechanical behavior difference between tension and compression is ignored. The main loading mode of nail penetration is compression, i.e., the mechanical composition under mechanical abuse loadings has not yet been established, thereby preventing precise prediction of the nail and jellyroll interface contact. Furthermore, excessive heat that ultimately leads to thermal runaway produced by a high current density and the redox reaction of lithium is also highly dependent on the previous mechanical loading and battery model. Few studies have attempted to provide a reasonable coupled computation model to solve the aforementioned emerging engineering problem for nail penetration.

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During the elastic deformation stage, the stress–strain relation can be expressed as follows [19]:

\[
\begin{bmatrix}
\sigma_{11} \\
\sigma_{22} \\
\sigma_{33} \\
\tau_{12} \\
\tau_{23} \\
\tau_{31}
\end{bmatrix} = \begin{bmatrix}
\frac{1}{E^j} & -\frac{\nu^j}{E^j} & 0 & 0 & 0 & 0 \\
-\frac{\nu^j}{E^j} & \frac{1}{E^j} & 0 & 0 & 0 & 0 \\
0 & 0 & 0 & \frac{1}{G^j} & 0 & 0 \\
0 & 0 & 0 & 0 & \frac{1}{G^j} & 0 \\
0 & 0 & 0 & 0 & 0 & \frac{1}{G^j}
\end{bmatrix} \begin{bmatrix}
\varepsilon_{11} \\
\varepsilon_{22} \\
\varepsilon_{33} \\
\gamma_{12} \\
\gamma_{23} \\
\gamma_{31}
\end{bmatrix}
\]

The Hill’48 failure criterion is used to define the mechanical yield surface of the jellyroll, which is written as:

\[
s_{\text{fail}} = \sqrt{F(\sigma_{11} - \sigma_{22})^2 + G(\sigma_{22} - \sigma_{33})^2 + H(\sigma_{11} - \sigma_{33})^2 + 2L\varepsilon^j_{11}^2 + 2M\varepsilon^j_{22}^2 + 2N\varepsilon^j_{33}^2},
\]

where the six constants \( F-N \) are the measures of anisotropy for each of the six components represented by the potentials \( (R_{11}, R_{12}, R_{13}, R_{21}, R_{22}, R_{23}) \). The hardening law for the jellyroll was discussed in our previous study [19]. This law, coupled with the dynamic loading (strain rate) effect and the SOC effect, can be expressed as follows:

\[
\sigma^j = \begin{cases} 
B^j(\varepsilon_{11}^{\text{strain}} + \sigma_0^j) e^{C^j \text{SOC}}, & \sigma_{11}^j \leq \sigma_{11}^{cp} \\
B^j(\sigma_{11}^{cp} - \sigma_0^j) e^{C^j \text{SOC}} C^j \varepsilon_{11}^{\text{strain}}, & \sigma_{11}^j > \sigma_{11}^{cp}
\end{cases}
\]

where \( B^j, n^j, C^j, D^j \) are the parameters determined through physical tests.

The equivalent strain failure shown below is chosen as the failure criterion:

\[
\tilde{\varepsilon}^j = \tilde{\varepsilon}_{11}^j
\]

where \( \tilde{\varepsilon}^j = \sqrt{\tilde{\varepsilon}_{11}^2 + \tilde{\varepsilon}_{22}^2 + \tilde{\varepsilon}_{33}^2} \).
In summary, the constitutive model is defined through 19 parameters, which are as follows:

- 6 elastic constants ($E_p, E_t, \nu_{pt}, \nu_{tp}, G_{pt}, G_{tp}$);
- 6 parameters that define the yield surface ($R_{11}^t, R_{22}^t, R_{12}^t, R_{13}^t, R_{23}^t, R_{33}^t$);
- 6 parameters that describe strain hardening ($\sigma_0, \epsilon_p, R_1, C, D, n$); and
- 1 parameter that describes the failure criterion ($\ell_t$).

Meanwhile, 18 parameters were previously determined in Ref. [19], and failure strain was established based on $\ell_t = 0.55$ by comparing the experiment and simulation values. The parameter values are summarized in Table 2.

### 2.2.2. Modeling the cathode

The cathode is regarded as an isotropic model for nail penetration even though it is slightly anisotropic in the $x_1$-$x_2$ direction [17]. The elastic-power hardening model [38] is chosen for modeling based on the tension test results and expressed as follows:

$$\left\{ \begin{array}{l} \sigma^e = E^e \epsilon^e \quad \text{when } \sigma^e \leq \sigma_0^e, \\ \sigma^e = A^e \epsilon^e^{\sigma^e} \quad \text{when } \sigma^e > \sigma_0^e. \end{array} \right. \quad (5)$$

where $A^e$ and $n^e$ are the material constants fitted from the experiment results in Ref. [17]. In addition, the von Mises criterion is used to define the yield surface as follows:

$$\sigma_{\text{Mises}} = \sqrt{(\sigma_{11}^c - \sigma_{22}^c)^2 + (\sigma_{22}^c - \sigma_{33}^c)^2 + (\sigma_{33}^c - \sigma_{11}^c)^2 + 2\tau_{12}^c + 2\tau_{23}^c + 2\tau_{31}^c}.$$  

The equivalent strain failure $\ell_t$ is determined from tension tests [17]. The values of the parameters are summarized in Table 2.

### 2.2.3. Modeling the anode

The anode is also regarded as an isotropic material, and the elastic-power hardening model [38] is proposed and expressed as follows:

$$\left\{ \begin{array}{l} \sigma^a = E^a \epsilon^a \quad \text{when } \sigma^a \leq \sigma_0^a, \\ \sigma^a = A^a \epsilon^a^{\sigma^a} \quad \text{when } \sigma^a > \sigma_0^a. \end{array} \right. \quad (7)$$

### Table 2

Summaries of material parameters.

<table>
<thead>
<tr>
<th>Parameters</th>
<th>Cathode</th>
<th>Separator</th>
<th>Anode</th>
<th>Jellyroll</th>
<th>Winding nail</th>
</tr>
</thead>
<tbody>
<tr>
<td>Density</td>
<td>4678 kg/m³</td>
<td>900 kg/m³</td>
<td>2270 kg/m³</td>
<td>2163.1 kg/m³</td>
<td>7850 kg/m³</td>
</tr>
<tr>
<td>Elastic constants</td>
<td>$E^c = 2940$ MPa [17]*</td>
<td>$E^s = 262.2$ MPa [17]*</td>
<td>$E^a = 5372$ MPa [17]*</td>
<td>$E^j = 1500$ MPa</td>
<td>$E^w = 207$ GPa</td>
</tr>
<tr>
<td>Poisson's ratio</td>
<td>$\nu^c = 0.3$ [17]</td>
<td>$\nu^s = 0.3$ [19]</td>
<td>$\nu^a = 0.3$ [17]</td>
<td>$\nu^j = 0.15$</td>
<td>$\nu^w = 0.3$ [19]</td>
</tr>
<tr>
<td>Strain hardening</td>
<td>$\sigma^c_0 = 185$ MPa</td>
<td>$\sigma^s_0 = 108.3$ MPa $n^s = 0.46$</td>
<td>$\sigma^a_0 = 32.84$ MPa</td>
<td>$\sigma^j_0 = 0.8$ MPa $C^1 = 1.103$</td>
<td>$\sigma^w_0 = 0.35$ GPa</td>
</tr>
<tr>
<td>Yield surface</td>
<td>$\ell^c_t = 0.0066$ [17]*</td>
<td>$\ell^s_t = 1$ [17]*</td>
<td>$\ell^a_t = 0.05$ [17]*</td>
<td>$\ell^j_t = 1$ [17]*</td>
<td>$\ell^w_t = 12.25$, 1.1, 12.17 [19]</td>
</tr>
<tr>
<td>Electrical conductivity</td>
<td>$k^c = 105.5$ m [11]</td>
<td>$k^s = 105.5$ m [27,28]</td>
<td>$k^a = 105.5$ m [24–26]</td>
<td>$k^j = 105.5$ m [24–26]</td>
<td>$k^w = 105.5$ m [24–26]</td>
</tr>
<tr>
<td>Diffusion coefficient</td>
<td>$D^c = 5 \times 10^{-13}$ [22,23]</td>
<td>$D^s = 5 \times 10^{-13}$ [27,28]</td>
<td>$D^a = 5 \times 10^{-13}$ [24–26]</td>
<td>$D^j = 5 \times 10^{-13}$ [24–26]</td>
<td>$D^w = 5 \times 10^{-13}$ [24–26]</td>
</tr>
<tr>
<td>Maximum concentration</td>
<td>$c^c_{eq} = 56.250$ mol/m³ [22,23]</td>
<td>$c^s_{eq} = 56.250$ mol/m³ [27,28]</td>
<td>$c^a_{eq} = 56.250$ mol/m³ [24–26]</td>
<td>$c^j_{eq} = 56.250$ mol/m³ [24–26]</td>
<td>$c^w_{eq} = 56.250$ mol/m³ [24–26]</td>
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<td>Separator</td>
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<td>Winding nail</td>
</tr>
<tr>
<td>Heat capacity</td>
<td>$C^c = 1269.2$ J/(kg K)</td>
<td>$C^s = 1978.16$ J/(kg K)</td>
<td>$C^a = 1437.4$ J/(kg K)</td>
<td>$C^j = 1347.4$ J/(kg K)</td>
<td>$C^w = 1347.4$ J/(kg K)</td>
</tr>
<tr>
<td>Effective thermal expansion coefficient</td>
<td>$\alpha^c = 9.615 \times 10^{-6}$ [42]</td>
<td>$\alpha^s = 13.32 \times 10^{-6}$ [42]</td>
<td>$\alpha^a = 4.06 \times 10^{-6}$ [42]</td>
<td>$\alpha^j = 4.06 \times 10^{-6}$ [42]</td>
<td>$\alpha^w = 4.06 \times 10^{-6}$ [42]</td>
</tr>
<tr>
<td>Thermal conductivity</td>
<td>$k^c = 1.58$ W/(m K)</td>
<td>$k^a = 0.344$ W/m K</td>
<td>$k^a = 1.04$ W/(m K)</td>
<td>$k^j = 28.2$ W/(m K)</td>
<td>$k^w = 1.068$ W/(m K)</td>
</tr>
</tbody>
</table>

* Estimated from the data.
where $E'$ and $E_{\text{eq}}'$ are fitted from the experiment results in Ref. [17]. The yield surface is defined well using the von Mises criterion. Moreover, the equivalent strain failure $\varepsilon^s$ determined by the tension experiment is chosen as the failure criterion. The parameter values are summarized in Table 2.

2.2.4. Modeling the separator

Celgard 2400, which is highly anisotropic, is used as the separator material [39,40]. Young’s modulus $E^s = 216.2$ MPa is obtained from the stress–strain curve in Ref. [17], and Poisson’s ratio is set to $\nu^s = 0.3$ [39]. The Hill’48 criterion is used for the yield surface as follows:

$$\sigma_{\text{tr}}^s = \sqrt{F^s(\sigma_{22}^s - \sigma_{33}^s)^2 + G^s(\sigma_{33}^s - \sigma_{11}^s)^2 + H^s(\sigma_{11}^s - \sigma_{22}^s)^2 + 2L^s\tau_{23}^s + 2M^s\tau_{13}^s + 2N^s\tau_{12}^s},$$

where $F^s - N^s$ are confirmed by the potentials ($K_{11}^s, K_{22}^s, K_{33}^s, K_{12}^s, K_{13}^s, K_{23}^s$), which are obtained from the experiment curves in Ref. [17]. The selected hardening model is also the power hardening model, which is shown as follows:

$$\sigma^w = A^w\varepsilon^{\text{eq}} + n^w \varepsilon^w,$$  \hspace{1cm} (9)

where $A^w$ and $n^w$ are the material constants fitted from the experiment in Ref. [17].

The strain failure criteria are also used for the separator [37] with failure strain anisotropy [17]. The expression $\varepsilon^s_{\text{eff}} = 1$ is chosen to describe the onset of failure [17]. The mechanical parameters of the separator are summarized in Table 2.

2.2.5. Modeling the winding nail

The winding nail is made of steel, the hardening model of which is described using the Johnson–Cook model [41]:

$$\sigma^w = (\sigma_0^w + B^w\varepsilon^{\text{eq}}^{\text{pl}})(1 + C^w\ln\varepsilon^{\text{eq}}),$$

where $\varepsilon^{\text{eq}}_{\text{pl}} = \frac{\dot{\varepsilon}}{\dot{\varepsilon}_0}$ is the dimensionless plastic strain rate with $\dot{\varepsilon}_0 = 1$ s$^{-1}$ as a reference strain rate; and $\sigma_0^w$, $B^w$ and $C^w$ are the parameters determined in Ref. [41]. The parameters are summarized in Table 2.

The finite element (FE) model for the jellyroll includes three parts: the winding nail, the homogeneous model for the jellyroll, and the outer layers. The winding nail and the outer layers are modeled using the shell element (C3D4 type in ABAQUS), and the homogeneous model uses the solid element (C3D8R type in ABAQUS). Element size is smaller within the vicinity of the penetration area. The model has a total of 188,649 elements (Fig. 1).

2.3. 1D battery model

The classical 1D battery model established by Newman et al. [20,21] was adopted and implemented in the numerical computation platform COMSOL Multiphysics [43]. Although the Newman model does not precisely describe the physics of battery electrochemical processes [44], it may accurately predict voltage change and heat generation under charge/discharge conditions, which are highly important for the coupled short circuit model. The 1D battery model can also represent the average electrochemical and thermal properties of the jellyroll. Thus, this model is chosen for this study to simplify computations. The 1D model has three parts: a negative electrode, a separator, and a positive electrode.

The main equations used are the mass balance and charge balance of the electrolyte [45,46], as follows:

$$\epsilon^i \frac{\partial c^i}{\partial t} = -D_{\text{eff}}^i \nabla c^i + \frac{\rho_i}{F}, \hspace{1cm} (11)$$

$$\dot{t} = -k_{\text{eff}} \nabla \varphi_i + 2k_{\text{eff}} R_{\text{li}} \frac{t}{F} \left( 1 + \frac{\mathrm{dln} f}{\mathrm{dln} c} \right) (1 - t_c) \nabla \ln c^i. \hspace{1cm} (12)$$

Additional details regarding the modeling can be found in Ref. [20]. The produced reaction, joules, resistance, and irreversible heat of the battery are expressed as follows [45]:

$$q_a = \int_0^l \left( i_1(\phi^1_0 - \phi^1) - E_{\text{eq}} \right) \mathrm{d}x,$$  \hspace{1cm} (13)

$$q_i = \int_0^l \kappa_{\text{eff}} \left( \frac{\partial \phi^i}{\partial x} \right)^2 + \kappa_{\text{eff}} \left( \frac{\partial \phi^i}{\partial x} \right)^2 + \kappa_{\text{eff}} \left( \frac{\partial \ln c^i}{\partial x} \right) \left( \frac{\partial \phi^i}{\partial x} \right) \mathrm{d}x,$$  \hspace{1cm} (14)

$$q_r = \int_0^l R_{\text{li}} \mathrm{d}x,$$  \hspace{1cm} (15)

$$q_t \approx 0,$$  \hspace{1cm} (16)

where $S' = 2dHL'$, and $l$ is the current equal to $iS'$. The total heat of the system is the sum of Eqs. (13)–(16).

The geometric parameters of the 1D model are summarized in Table 1. In the 1D model, the positive and negative current collectors are insignificant because of small resistances. Similar to the modeling method presented in Section 2.1, the 1D battery model uses half of the thickness of the cathode and the anode, as well as the entire thickness of the separator. The cross section of this model is set to twice the unfolded area of the jellyroll.

2.4. Short circuit modeling

The short circuit model contains a 1D battery model, a representative short circuit model, and a 3D thermal model. The relationship among the three models including variable and parameter transferring logic, is illustrated in Fig. 2. The representative short circuit model is proposed to predict the excessive heat caused by short circuit. Assuming no explosion of the positive/negative collectors during nail penetration, the dominant cathode–anode short circuit mode is chosen of four internal short circuit modes [29].

For the selected internal short circuit model, the mechanical failure of the separator is the primary reason for the short circuit [5,29,37,40,47]. The short circuit resistances of the cathode, anode, and nail are configured in series. The nail has high electrical conductivity (nearly $10^6$ S/m$^2$), and the head produced by the nail is ignored in this analysis. The geometry of the 1D representative short circuit model is depicted in Fig. 2. The model only contains a cathode and an anode with lengths $L^m$ and $L^n$, respectively. The cross section $S'$ is related to the radius of the puncture nail, which is

$$S' = \pi R_{\text{nl}}^2.$$  \hspace{1cm} (17)
The governing equations for the electrical behavior are listed as follows [37]:

\[
\vec{j} = \kappa^e \nabla \phi ,
\]

\[\vec{E} = -\nabla \phi,\]

\[E_j = \frac{j}{k_{\phi}^e}.
\]

The 3D thermal model is used to calculate heat conduction. A half model and the symmetry boundary conditions are used to simplify the computation. This model contains three components: the jellyroll, the short circuit area, and air. An open boundary is set for air, and a symmetric boundary is set for the symmetry plane (Fig. 2).

The governing equation for the thermal model is [48,49]

\[\rho C_T \frac{\partial T}{\partial t} = \nabla \cdot (k \nabla T) + q.
\]

On the one hand, the 1D battery model and the representative short circuit model are coupled through the cell voltage \(V\) and the current density \(i\) of the short circuit model. This quantitative relationship is expressed as

\[V^i = V^{st},\]

\[i^i = N^{st}i^{st},\]

where \(N^{st}\) is the number of short circuit parts in parallel (dependent on the time/displacement of the nail), which can be estimated using the following functions:

\[N^{st}(t) = 1 + \left[ \frac{d_{\mu t}(t) - d_{\mu}}{1 - \frac{d_{\mu}}{d_{\mu t}(t)}} \right] \left( L^{rg} + L^{se} + L^{ps} \right),\]

where \([\ ]\) is a round down function; \(d_{\mu t}(t)\) is the penetration displacement with time; \(d_{\mu}\) is the separator failure displacement; \(t\) is time; and \(d_{\mu t}(t)\) is related to the penetration velocity, which is expressed as follows:

\[d_{\mu t}(t) - d_{\mu} = \nu_{\mu t}.\]

On the other hand, the 1D battery model and the 3D thermal model are coupled with the heat production rate \(q^l\) and the temperature \(T\) of the battery model, as well as the loading heat rate \(q^{3D}\) and the average temperature \(T^{3D}\) of the thermal model. This relationship is described as

\[q^{3D} = q^l \text{ and } T^l = T^{3D}.
\]

Meanwhile, the short circuit representative model and the 3D thermal model are bridged with the heat production rate \(q^{st}\) of the short circuit model and the overall heat rate \(p^{3D}\). This relationship is expressed as

\[p^{3D} = q^{st}S^{st}(L^{rg} + L^{ps})N^{st}(t)/2.
\]

3. Results

3.1. Model validation

3.1.1. Validation of the 3D mechanical model

To ensure convergence within the modeling, three models were established with (i) only a homogenous jellyroll part; (ii) a one-layer set of cathode, anode, and separator, together with the rest of the homogenous jellyroll; and (iii) a two-layer set, together with the rest of the homogenous jellyroll. Fig. 3(a) shows the comparison between the compression experiment and the three modeling results. A reasonably good fit was observed, and material/structure failure was accurately predicted. The exact moments of the contact and material failure must be identified for nail penetration problems, and thus, the 3D model with a one-layer set with two layers of separators was adopted.

3.1.2. Validation of the 1D battery model

Without losing generality, Fig. 3(b) shows the calibration of the 1D battery model with the charging/discharging tests of the cell. A high correlation was observed, thereby validating the 1D battery model against the target 18650 LIB.

3.1.3. Validation of the short circuit model

A nail penetration experiment was conducted to calibrate the established short circuit model. The total penetration displacement was 4 mm. As shown in Fig. 3(c), reasonable agreements were achieved for both voltage and temperature time history profiles. In particular, the critical temperature rise and voltage drop points i.e., \(t = 125\) s, were precisely determined. The simulation data exhibit a small deviation with the experimental data when time is over 200 s. The present model does not reflect the temperature dependence of the mechanical properties because of the lack of experiment data.
Fig. 3. (a) Load–displacement curve of the experiments and simulations using the 3D failure model in compression. (b) Voltage–time curves of the experiments and simulations using the 1D battery model in the charging/discharging tests. (c) Temperature and voltage–time curves of the experiments and simulations using the 1D battery model in the nail penetration test.

Fig. 4. Force, voltage, and maximum increased temperature–time curves of the jellyroll under nail penetration. The failure figure of the components and the temperature field distribution of the jellyroll are also depicted.
3.2. General results

The overall mechanical, electrochemical, and thermal behaviors of the jellyroll can be divided into three stages based on the force, voltage, and temperature time history curves illustrated in Fig. 4. In Stage I (the mechanical deformation stage), the jellyroll experienced elastic and plastic mechanical deformations until it buckled while sustaining nearly constant electrochemical properties, except for a minor voltage increase reported in Ref. [50]. The cathode and the anode in the outer layers progressively failed. In Stage II (the penetration stage), after the buckling of the jellyroll structure (during which the anode and the cathode were also fractured), the separator with a large failure strain began to bear the load. As the displacement caused by the nail continued, the separator was penetrated once it reached mechanical failure strain. The cutoff point for this stage was the failure point of the outer layer of the separator. This critical point was predicted well by the 3D mechanical model compared with the tests. In Stage III (the short circuit stage), the cathode–anode short circuit began once the separator failed. Voltage decreased and temperature increased. The gradient of the voltage and temperature change increased as a function of time because the involved short circuit components, i.e., \( N^o (t) \) of Eq. (25), increased with further penetration displacement. As shown in Fig. 4, the temperature of the short circuit area increased sharply at the beginning, thereby causing the overall temperature of the cell to increase through heat conduction. These findings agree well with those of the experiment. A voltage drop was also observed in Stage III, thereby demonstrating reasonable consistency with the voltage change profile during the experiment. The deviation with the experimental data can be attributed to the shortcoming of the short circuit model, which results from the absence of a temperature-dependent mechanical behavior.

4. Discussion

To further explore the governing factors in LIB short circuit behavior during nail penetration, a series of parametric studies, including nail shape, nail size, SOC value, penetration speed, and penetration distance, was conducted using the aforementioned validated computation model. The parameter baselines were set as a spherical penetration nail with \( R^p = 1 \) mm, \( SOC = 0.6 \), \( \nu_{pn} = 1 \) mm/min, and \( d_{pn} = 4 \) mm. Notably, when one parameter was changed, the others remained the same.

4.1. Penetration with various nail shapes

Four typical end shapes of nails were selected, namely, ellipsoid (with a short shaft radius equal to half of the long axis), flat, cone (with a cone angle of 90°), and sphere, as shown in Fig. 5(a). The mechanical responses for different nail shapes evidently differed because large contact areas with the jellyroll resulted in considerable reaction forces under the same nail displacement. By contrast, the cone-shaped nail demonstrated an early force drop because of the sharp nail tip, thereby imposing an elevated stress concentration.

This model may also be capable of predicting failure of the outer layers. In general, the outer cathode and the anode fail at a smaller displacement compared with that of the separator because of their lower mechanical failure strain values. The separator typically fails at relatively large strains (deformation), and in some cases, even after the overall buckling of the jellyroll. This observation indicates that the drop in mechanical load cannot be used as the indicator for the cathode–anode short circuit of the jellyroll. Similar qualitative phenomena were also observed in the bending and indentation mechanical tests, thereby showing that the internal short circuit occurred after the force drop, whereas the internal short circuit occurred before the buckling in compression tests in previous investigations [18,50].

The failure displacements of the cathode and the anode did not vary among nail shapes, whereas the failure displacement of the separator did. Among the tested nail shapes, the spherical nail appeared to be the safest because of its blunt head, which probably delayed the failure of the separator, as shown in Fig. 5(b).

Different mechanical behaviors resulted in various electrochemical and thermal behaviors following the short circuit. Fig. 5(c) depicts the current–time curves after the short circuit of each nail shape. All shapes demonstrated an increased current because of the number of involved short circuit separator layers, and then became stable until penetration ceased. Fig. 5(c) shows that the current of the jellyroll penetrated by the sphere nail is the first to become stable and has the lowest stable current value. This result can be attributed to the spherical nail having a larger short...
circuit displacement. Thus, the failure of the separator value was the smallest at the same penetration displacement, which resulted in the lowest stable current. As shown in Fig. 5(c), the penetration of the ellipsoid nail has the shortest plateau-maintaining stable current because of the high current and the rapidly decreasing capacity of the jellyroll. Voltage dropped after short circuit occurred, and the voltage drop rate was highly dependent on the short circuit current. Thus, voltage dropped slowly at the beginning for a smaller short circuit and then increased gradually. An evident turning point of the voltage was observed as a result of the high potential change rate of the cathode and the anode at a low capacity [22,25]. Temperature evolution during nail penetration was determined based on current and voltage. For example, for the ellipsoid-shaped nail, the temperature decreased after the peak because of the rapid and steep drop in voltage, as shown in Fig. 5(e). To summarize, the spherical nail caused the lowest short circuit current and the lowest temperature, while exhibiting improved capability to maintain voltage. Thus, spherical nail penetration is the least dangerous case for LIBs.

4.2 Penetration with various nail sizes

Evidently, small nails can easily penetrate the jellyroll, whereas large ones cause a large short circuit area. Fig. 6(a) shows the load–displacement curves for the nail penetration simulation with nail sizes of \( R_{nl} = 0.25–1 \text{ mm} \). Large nails clearly led to a considerable reaction force and large buckling displacement, in addition to internal short circuit displacement (i.e., separator failure displacement was also larger for larger nails). The relationship between internal short circuit displacement and nail size can be described as

\[
d_f = 3.3 R_{nl}.
\]  

After an internal short circuit occurred, large nails caused large short circuit areas, thereby leading to large cross-section areas \( S_{int} \). As shown in Fig. 6(c), the current increase rate is proportional to the square of the nail size, i.e., \( R_{nl}^2 \). The current increasing time was estimated using

\[
t_c = \frac{d_{pm} - 3.3 R_{nl}^2}{v_{pm}}(d_f \geq 3.3 R_{nl}).
\]  

The stable current \( I_{stable} \) is proportional to \( R_{nl}^2 t_c \), which is expressed as

\[
I_{stable} \propto \frac{d_{pm} - 3.3 R_{nl}^2}{v_{pm}} R_{nl}^2(d_f \geq 3.3 R_{nl}).
\]  

The extreme value was reached when \( R_{nl} = 0.202 d_{pm} \), where \( I_{stable} \) assumed a maximum value. Thus, the penetration displacement was a constant value. The parameter \( I_{stable} \) initially increased, and then decreased as \( R_{nl} \) increased, as illustrated in Fig. 6(c).

The voltage dropping rate and the temperature increasing rate increased prior to the achievement of a stable current with increasing \( R_{nl} \). Once the current became stable, voltage drop and temperature gradient initially increased, and then decreased with increasing \( R_{nl} \), as shown in Fig. 6(d) and (e).

4.3 Penetration with various SOCs

The mechanical behaviors of LIBs have been proven to be SOC dependent in previous studies [50], where LIBs with high SOCs have exhibited high stiffness. Consequently, the reaction force of LIBs with high SOCs is considerable during nail penetration, as shown in Fig. 7(a). Furthermore, force drop displacements also demonstrate a positive correlation with SOC values.

The failure displacement of the separator (short circuit displacement) presents a nearly linear relationship with SOC as follows:

\[
d_f = 3.12 - 0.75 SOC.
\]  

A previous study [50] conducted compression experiments on LIBs with various SOCs, and the results showed that the internal short displacement and the SOC exhibited a linear relationship, with a highly similar slope to that in Eq. (31).

The current, voltage, and maximum increased temperature–time curves are shown in Fig. 7(c)–(e). The current increasing rate slightly varied for different SOCs at varying initial voltages. The
capacity of the jellyroll in low SOCs (e.g., SOC = 0.2 and 0.4) was depleted soon after the stable current was established, and voltage and current subsequently decreased as temperature changed from increasing to decreasing. However, for the jellyroll with a high SOC, a stable current was maintained for a sufficiently long period, such that the temperature exceeded the thermal runaway temperature, as shown in Fig. 7(e). The present model did not consider the thermal runaway behavior to include a discussion of temperatures exceeding 128 °C [10].

4.4. Penetration at various speeds

Mechanically, penetration at high speeds caused the dynamic hardening of the jellyroll material. Compared with the quasi-static conditions, the reaction force at increased speeds was significantly higher (Eq. (10)). However, the short circuit displacement exhibited no evident regularity with penetration velocity, as shown in Fig. 8(a) and (b). Electrochemical and thermal behaviors were simulated at different loading speeds, including 0.01, 0.1, 1, 10, and 10,000 mm/s. The computation results are presented in Fig. 8(c)–(e). The stable current was the same for all four cases. However, the current increasing rate was highly related to penetration speed, although the current increasing rate demonstrated reduced sensitivity for speeds >1 mm/s. Furthermore, the voltage and maximum temperature–time curves were nearly overlapping, thereby indicating that penetration speed did not significantly affect thermal and electrochemical behaviors once the loading speed was within a selected domain.

Fig. 7. Results of different SOCs in penetration: (a) load–displacement curve, (b) relationship between failure displacement and shape, (c) current–time curve after a short circuit, (d) voltage–time curve after a short circuit, and (e) maximum increased temperature–time curve after a short circuit.

Fig. 8. Results of different puncture speeds during penetration: (a) load–displacement curve, (b) relationship between failure displacement and shape, (c) current–time curve after a short circuit, (d) voltage–time curve after a short circuit, and (e) maximum increased temperature–time curve after a short circuit.
modified based on the Newman model and used to calculate the electrochemical behavior of the jellyroll. The 3D failure model, which used a homogenous model with external component layers, indicated internal short circuit displacement caused by the failure of the separator. Lastly, the coupled short circuit model was used to calculate electrochemical and thermal behaviors following an internal short circuit. These three models were validated separately, and the integrated model was also verified via experiments.

A series of parametric studies on various nail sizes, shapes, SOC values, penetration speeds, and nail tip displacements was conducted using the established integrated model. The following important results of the parametric studies were obtained for 18650 LIB.

- For different nail shapes, the order of the capability to deform the jellyroll is cone > sphere > ellipsoid > flat. The order of short circuit displacement is sphere > cone > flat > ellipsoid. The order of increasing temperature rate is sphere < cone < flat < ellipsoid.
- For penetration nail sizes, short circuit displacement and needle radial exhibited the linear relationship of \( d_n = 3.3R^{0.2} \). The extreme value of the stable current was achieved when \( R^{0.7} = 0.202d_n \).
- For different SOCs, short circuit displacement presented a linear relationship with SOC, i.e., \( d_n = 3.12 - 0.75SOC \). For the jellyroll with a higher SOC, the current increasing rate and the stable current were slightly higher, and the stable current lasted longer.
- For different penetration distances, a large puncture distance caused a sharp temperature increase and might easily trigger the thermal runaway of the jellyroll.
- For different penetration speeds, short circuit displacement presented no difference. Penetration speed did not significantly affect thermal and electrochemical behaviors once loading speed was within the range of 1–10,000 mm/s.

These results can be used as bases for setting more reliable and appropriate penetration standards including test conditions, loadings, penetrator sizes and shapes, for various engineering applications. On the other hand, the coupled mechanical–electrochemical–thermal simulation method can be used to guide the safety design of lithium-ion batteries for various service conditions.

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